


<b>Search Notes</b> 	<b>Application/Control No.</b> 10568624	<b>Applicant(s)/Patent Under Reexamination</b> JONG, CHOON
	<b>Examiner</b> Neil Abrams	<b>Art Unit</b> 2839

SEARCHED			
Class	Subclass		Examiner
439	94 113 114 140	118 119 120	6-8-2008 na

SEARCH NOTES		
Search Notes	Date	Examiner
All subs to date	10-29-2008	na

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See interference search attachment	10-29-2008	na

	/Neil Abrams/ Primary Examiner.Art Unit 2839
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